## 3. CMOS Technology

6.004x Computation Structures Part 1 – Digital Circuits

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#### **Combinational Device Wish List**



- ✓ Design our system to tolerate some amount of error
   ⇒ Add positive noise margins
   ⇒ VTC: gain>1 & nonlinearity
- $\checkmark$  Lots of gain  $\Rightarrow$  big noise margin
- ✓ Cheap, small
- ✓ Changing voltages will require us to dissipate power, but if no voltages are changing, we'd like zero power dissipation
- ✓ Want to build devices with useful functionality (what sort of operations do we want to perform?)

### **N-Channel MOSFET: Physical View**



MOSFETs (metal-oxide-semiconductor field-effect transistors) are four-terminal voltage-controlled switches. Current flows between the diffusion terminals if the voltage on the gate terminal is large enough to create a conducting "channel", otherwise the mosfet is off and the diffusion terminals are not connected.

## N-Channel MOSFET: Electrical View

The four terminals of a Field Effect Transistor (gate, source, drain and bulk) connect to conductors that generate a set of electric fields in the channel region which depend on the relative voltages of each terminal.  $V_{DS} < V_{GS} - V_{TH}$ 





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#### **FETs Come in Two Flavors**

NFET: n-type source/drain diffusions in a p-type substrate. Positive threshold voltage; inversion forms ntype channel





PFET: p-type source/drain diffusions in a n-type substrate. Negative threshold voltage; inversion forms p-type channel.





The use of both NFETs and PFETs – complimentary transistor types – is a key to CMOS (complementary MOS) logic families.

## **CMOS Recipe**

If we follow two rules when constructing CMOS circuits, we can model the behavior of the mosfets as simple *voltage-controlled switches*:

> Rule #1: only use NFETs in pulldown circuits Rule #2: only use PFETs in pullup circuits





nfet "off"

## **CMOS Inverter VTC**



When  $V_{IN}$  is low, the nfet is off and the pfet is on, so current flows into the output node and  $V_{OUT}$  eventually reaches  $V_{DD}$  (>  $V_{OH}$ ) at which point no more current will flow. Pfet "on" Steady state reached when  $V_{out}$  reaches value where  $I_{pu} = I_{pd}$ .

> When  $V_{IN}$  is high, the pfet is off and the nfet is on, so current flows out of the output node and  $V_{OUT}$  eventually reaches GND (<  $V_{OL}$ ) at which point no more current will flow.

> > Pfet "off" nfet "on"

When V<sub>IN</sub> is in the middle, both the pfet and nfet are "on" and the shape of the VTC depends on the details of the devices' characteristics. CMOS gates have very high gain in this region (small changes in V<sub>IN</sub> produce large changes in V<sub>OUT</sub>) and the VTC is almost a step function.
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 $V_{IH}$ 

 $V_{\rm IL}$ 

#### Beyond Inverters: Complementary pullups and pulldowns

Now you know what the "C" in CMOS stands for!

We want *complementary* pullup and pulldown logic, i.e., the pulldown should be "on" when the pullup is "off" and vice versa.



Since there's plenty of capacitance on the output node, when the output becomes disconnected it "remembers" its previous voltage -at least for a while. The "memory" is the load capacitor's charge. Leakage currents will cause eventual decay of the charge (that's why DRAMs need to be refreshed!).



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## A Pop Quiz!



#### **General CMOS Gate Recipe**

Step 1. Figure out the pullup network that does what you want, *e.g.*,

$$F = \overline{A} + \overline{B} \cdot \overline{C}$$

(Determine what combination of inputs generates a high output)

Step 2. Walk the hierarchy replacing nfets with pfets, series subnets with parallel subnets, and parallel subnets with series subnets

Step 3. Combine pfet pullup network from Step 1 with nfet pulldown network from Step 2 to form a fully-complementary CMOS gate.



#### **CMOS Gates Are Naturally Inverting**

In a CMOS gate, rising inputs  $(0 \rightarrow 1)$  lead to falling outputs

- NFETs go from "off" to "on"
   → pulldown paths connected
   → output may be connected to ground
- PFETs go from "on" to "off"
  - $\rightarrow$  pullup paths disconnected
  - $\rightarrow$  output may be disconnected from V<sub>DD</sub>

For CMOS gate:

- All inputs 0
- $\rightarrow$  nfets off, pfets on
- $\rightarrow$  output must be 1 All inputs 1
- $\rightarrow$  nfets on, pfets off
- $\rightarrow$  output must be 0

Corollary: you can't build positive logic, e.g., AND, with one CMOS gate

 $\begin{array}{c|ccccc}
A & B & A \cdot B \\
\hline 0 & 0 & 0 \\
AND, & 0 & 1 & 0 \\
te & 1 & 0 & 0 \\
\hline 1 & 1 & 1 & 1 \\
\hline A=1, B rising... & & & & \\
\end{array}$ 

*Oops, output is also rising*!

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#### **CMOS Timing Specifications**



#### **Propagation Delay**

Propagation delay (t<sub>PD</sub>): An UPPER BOUND on the delay from valid inputs to valid outputs.



#### **Contamination Delay**

Contamination delay ( $t_{CD}$ ): A LOWER BOUND on the delay from any invalid input to an invalid output



#### The Combinational Contract



#### Acyclic Combinational Circuits

If NAND gates have a  $t_{PD}$  = 4nS and  $t_{CD}$  = 1nS



#### One Last Timing Issue...



Recall the rules for *combinational devices*:

Output guaranteed to be valid when <u>all</u> inputs have been valid for at least  $t_{PD}$ , and, outputs may become invalid no earlier than  $t_{CD}$  after an input changes!

Many gate implementations—e.g., CMOS adhere to even tighter restrictions.

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# What Happens In This Case? CMOS NOR: B A CMOS NOR: B CMOS NOR: CMOS NOR:

**LENIENT** Combinational Device:

Output guaranteed to be valid when <u>any</u> combination of inputs sufficient to determine the output value has been valid for at least t<sub>PD</sub>. *Tolerates transitions -- and invalid levels -- on irrelevant inputs!* 

NOR:
 
$$A \ B \ Z$$
 Lenient
  $A \ B \ Z$ 

 0
 0
 1
 NOR:
  $0 \ 0 \ 1$ 

 0
 1
 0
  $X \ 1 \ 0$ 

 1
 0
 1
  $X \ 1 \ 0$ 

 1
 1
 0

 A \ B \ Z
  $X \ 1 \ 0$ 

A \_\_\_\_\_\_ B \_\_\_\_\_ Z \_\_\_\_\_

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## Summary

- CMOS
  - Only use NFETs in pulldowns, PFETs in pullups → mosfets behave as voltage-controlled switches
  - Series/parallel Pullup and pulldown switch circuits are complementary
  - CMOS gates are naturally inverting (rising input transition can only cause falling output transition, and vice versa).
  - "Perfect" VTC (high gain,  $V_{OH} = V_{DD}$ ,  $V_{OL} = GND$ ) means large noise margins and no static power dissipation.
- Timing specs
  - t<sub>PD</sub>: upper bound on time from valid inputs to valid outputs
  - t<sub>CD</sub>: lower bound on time from invalid inputs to invalid outputs
  - If not specified, assume  $t_{CD} = 0$
  - Lenient gates: output unaffected by some input transitions
- Next time: logic simplification, other canonical forms

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